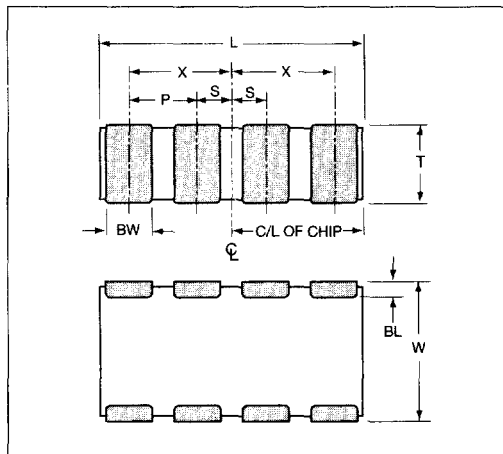


# Transient Voltage Suppressors

## MultiGuard 4-Element TVS Array - 0612



### HOW TO ORDER

**MG 06 4 S 14 A 300 T**  
 ① ② ③ ④ ⑤ ⑥ ⑦ ⑧

- ① **MultiGuard**
- ② **Chip Size:** 06=0612
- ③ **Configuration:** 4=4 Elements
- ④ **Style:** S=Standard Construction  
L=Low Capacitance
- ⑤ **Working Voltage:**  
05=5.6V 14=14.0V  
09=9.0V 18=18.0V
- ⑥ **Energy Rating:**  
A=0.10 Joules  
X=0.05 Joules
- ⑦ **Clamping Voltage:**  
150=15.5V 400=40.0V  
200=20.0V 500=50.0V  
300=30.0V
- ⑧ **Packaging (Pcs/Reel):**  
D=1,000  
R=4,000  
T=10,000

### Dimensions: millimeters (inches)

L	W	T	BW	BL	P	X	S
3.20±0.2 (.126±.008)	1.60±0.2 (.063±.008)	1.22 MAX (.048 MAX)	0.41±0.1 (.016±.004)	0.18±0.05 (.007±.002)	0.76 REF (.030 REF)	1.14±0.1 (.045±.004)	0.38±0.1 (.015±.004)

### Electrical Characteristics Per Element

AVX Part Number	Working Voltage	Breakdown Voltage	Clamping Voltage	Peak Current	Transient Energy	Capacitance	Inductance
Symbol	$V_{WM}$	$V_C$	$V_C$	$I_{peak}$	$E_{trans}$	C	$L_L$
Units	Volts (max.)	Volts	Volts (max.)	Amp. (max.)	Joules (max.)	pF (typ.)	$\mu$ Amp (max.)
Test Condition	<50 $\mu$ A	1nA DC	8/20 $\mu$ S†	8/20 $\mu$ s	10/1000 $\mu$ S	0.5Vrms @: 1MHz	@ $V_{WM}$
<b>MG064S05A150</b>	5.6	7.6 - 9.3	15.5	30	0.1	825	<1.0
<b>MG064S09A200</b>	9.0	11.0 - 14.0	20	30	0.1	550	<1.0
<b>MG064S14A300</b>	14.0	16.5 - 20.3	30	30	0.1	425	<1.0
<b>MG064S18A400</b>	18.0	22.9 - 28.0	40	30	0.1	220	<1.0
<b>MG064L18X500</b>	≤18.0*	N/A	50	30	0.05	<75	<1.0

\*Test Condition = <25 $\mu$ A

$V_{WM}$ —Maximum steady-state DC operating voltage the varistor can maintain and not exceed 50 $\mu$ A leakage current

$V_B$ —Voltage across the device measured at 1mA DC current

$V_C$ —Maximum peak voltage across the varistor measured at a specified pulse current and waveform

† Transient Energy Rating      Pulse Current & Waveform  
 .1 Joule                              2A 8/20 $\mu$ S  
 .05 Joules                             1A 8/20 $\mu$ S

$I_{peak}$ —Maximum peak current which may be applied with the specified waveform without device failure

$E_{trans}$ —Maximum energy which may be dissipated with the specified waveform without device failure

C—Device capacitance measured with zero volt bias at 0.5Vrms and 1MHz

$L_L$ —Device inductance measured with a current edge rate of 100mA/nS

Additional information on this product is available from AVX's catalog or AVX's FAX Service.  
 Call 1-800-879-1613 and request document #105. Visit our website <http://www.avxcorp.com>

